SHIGA7.045APC PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Masuda et al.

Appl. No. : 10/568,126

Filed: February 14, 2006

For : POSITIVE PHOTORESIST

COMPOSITION AND RESIST

PATTERN

Examiner : Chu, John S Y.

Group Art Unit : 1752

AMENDMENT AND RESPONSE TO OFFICE ACTION

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the Office Action mailed **June 27, 2007**, please consider the following amendments and remarks:

Amendments to the claims are reflected in the listing of claims which begin on page 2 of this paper.

Remarks/Arguments begin on page 4 of this paper.